

# Quantification of TEM/STEM Data

Lecture 6  
: Machine Learning in STEM

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Machine Learning in STEM  
June 2023

# Why Quantification?

- ▶ Comparison with Theory
- ▶ Comparison of Different Methods
- ▶ Comparison of Different Materials
- ▶ Comparison of Different Instruments
- ▶ Comparison of Different Days
- ▶ Comparison of Different Parts of Datasets
  
- ▶ Additional Information

GOOD TRAINING DATASETS and WIDE APPLICABILITY

# What is the problem?

## Problem

- ▶ Electrons interact strongly with matter

## Advantage

- ▶ Electrons interact strongly with matter

## Opportunity for Machine Learning

- ▶ Electrons interact strongly with matter

# How Precise Can EELS and Imaging in TEM/STEM Be?

- ▶ How well can we determine absolute atom positions and strain
  - ▶ Relative positions are well determined
  - ▶ Strain is a tensor
- ▶ How well can we quantify electron energy-loss data
  - ▶ Composition
  - ▶ Bonding
  - ▶ Optical Response

# Images – Z-contrast Images

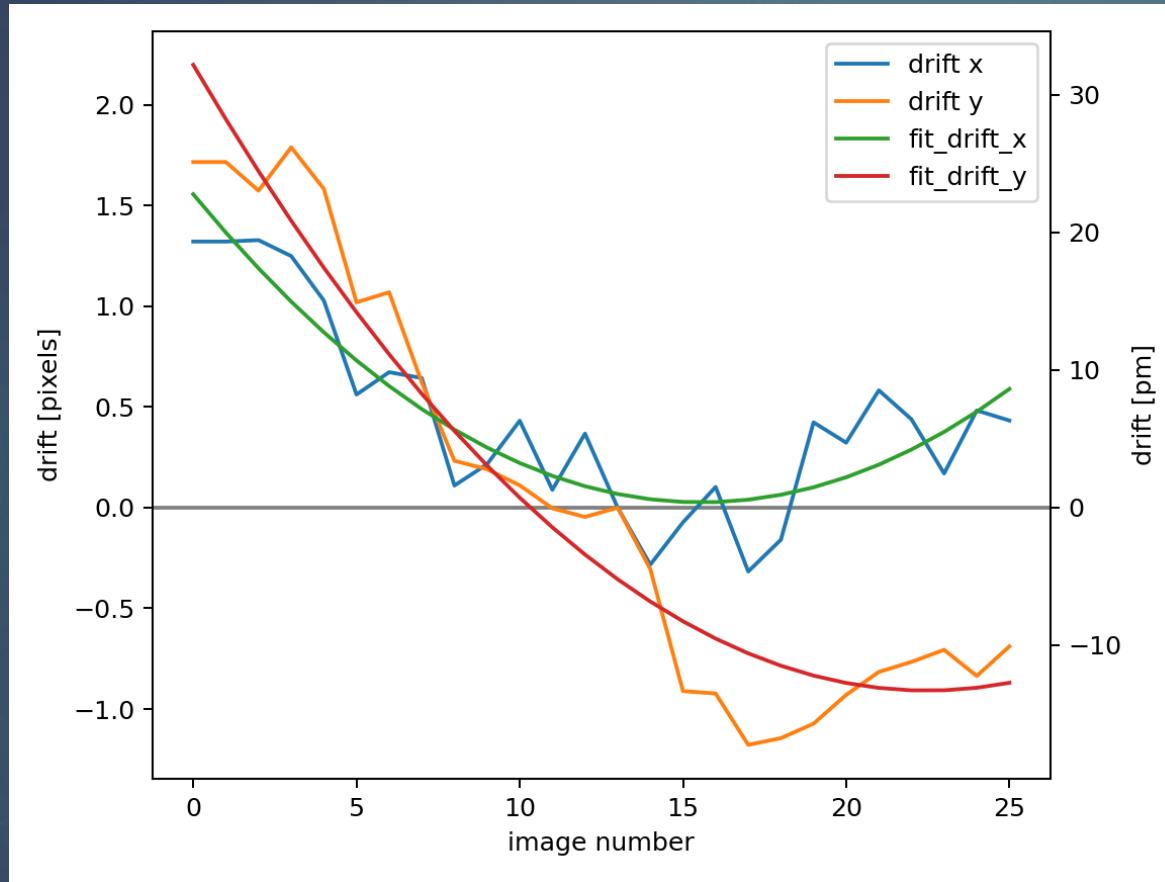
## Artefacts

- ▶ Sample drift
- ▶ Noise
  - ▶ Uncertainty in atom position
- ▶ Scan distortions
  - ▶ Uncertainty in absolute position determination
  - ▶ Prevents strain determination

# Data Analysis

- ▶ All data analysis is done with jupyter notebooks
- ▶ Data are represented as **sidpy datasets**
- ▶ Data and results are stored in **pynsid format**
- ▶ Most routines are made publicly available through **pycroscopy**  
**at github page**
- ▶ **Notebooks will explain the basics.**

# Sub-Pixel Accuracy in Drift Correction



Removal of all the random drift from dataset is essential.  
**rigid registration**

If drift from frame to frame is small no additional correction is necessary.

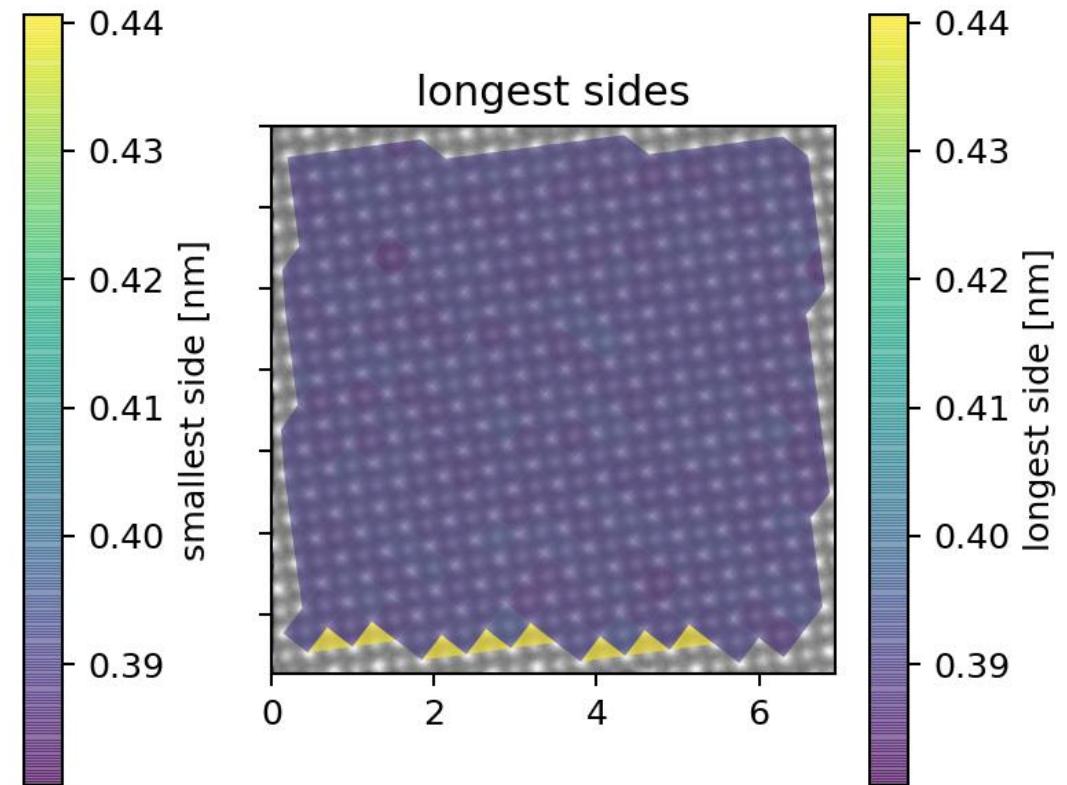
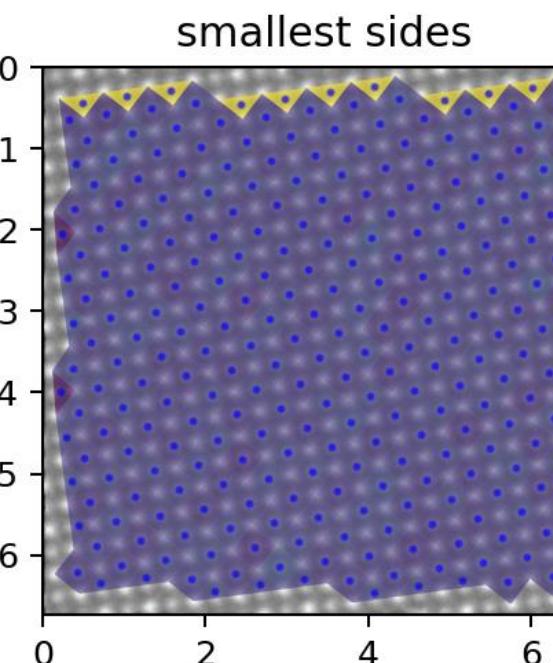
We need:

**stacks of images with low sample drift.**

Question: Is the jitter true or should we use smooth fit?

standard deviation of jitter in x direction: 2.98 pm  
standard deviation of jitter in y direction: 3.62 pm

# Tetragonal Distortion



After:

distortion correction  
(same dataset)  
rigid registration  
non-rigid registration  
atom finding  
atom position refinement  
unit cell finding

Evaluation of Squares Only  
(not of triangles at rim)

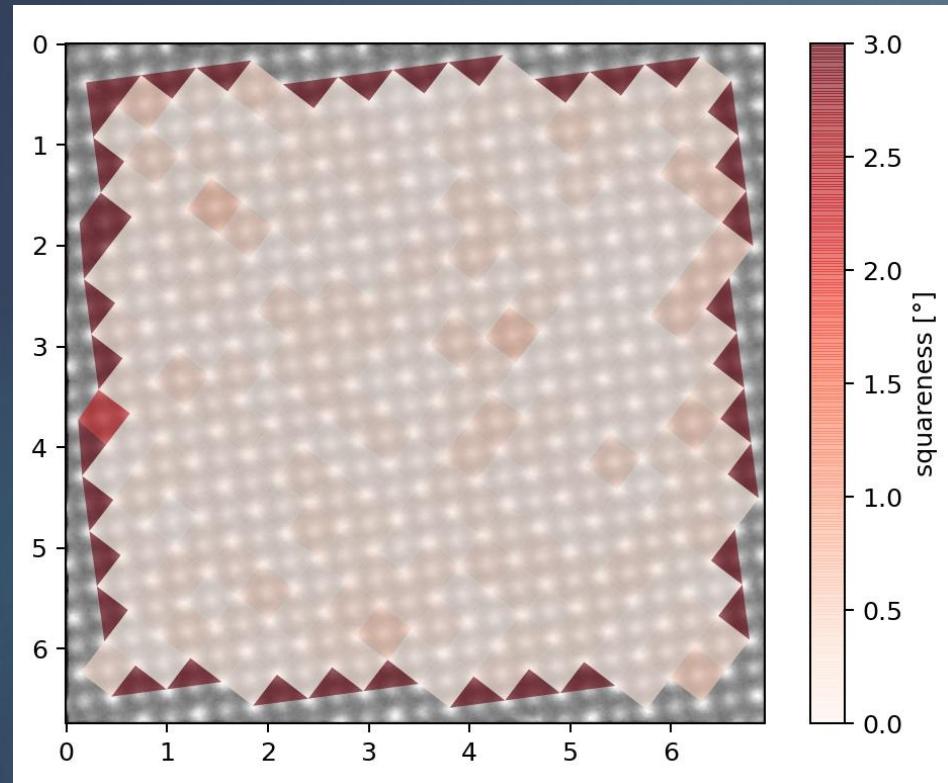
Median of smallest side: 0.3894 nm  
with standard deviation: 2.4 pm

Median of longest side: 0.3915 nm  
with standard deviation: 0.8 pm

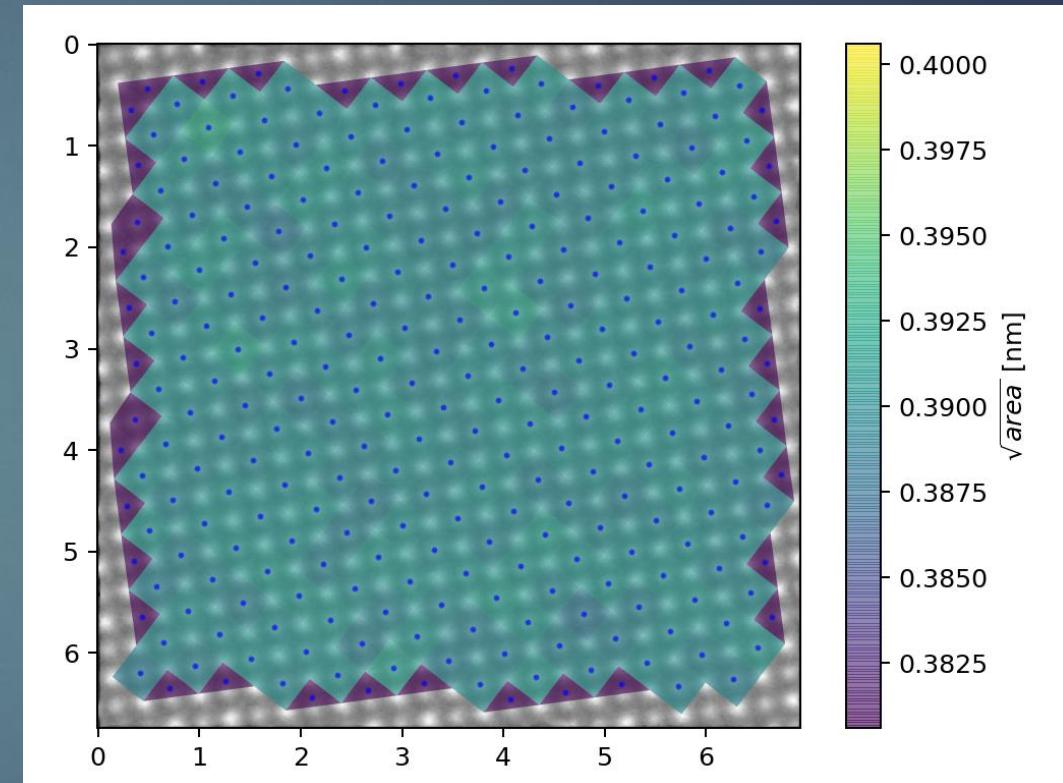
pixel size is 14.6 pm

# Unit Cell Scale

Evaluation of Squares Only  
(not of triangles at rim)  
pixel size is 14.6 pm

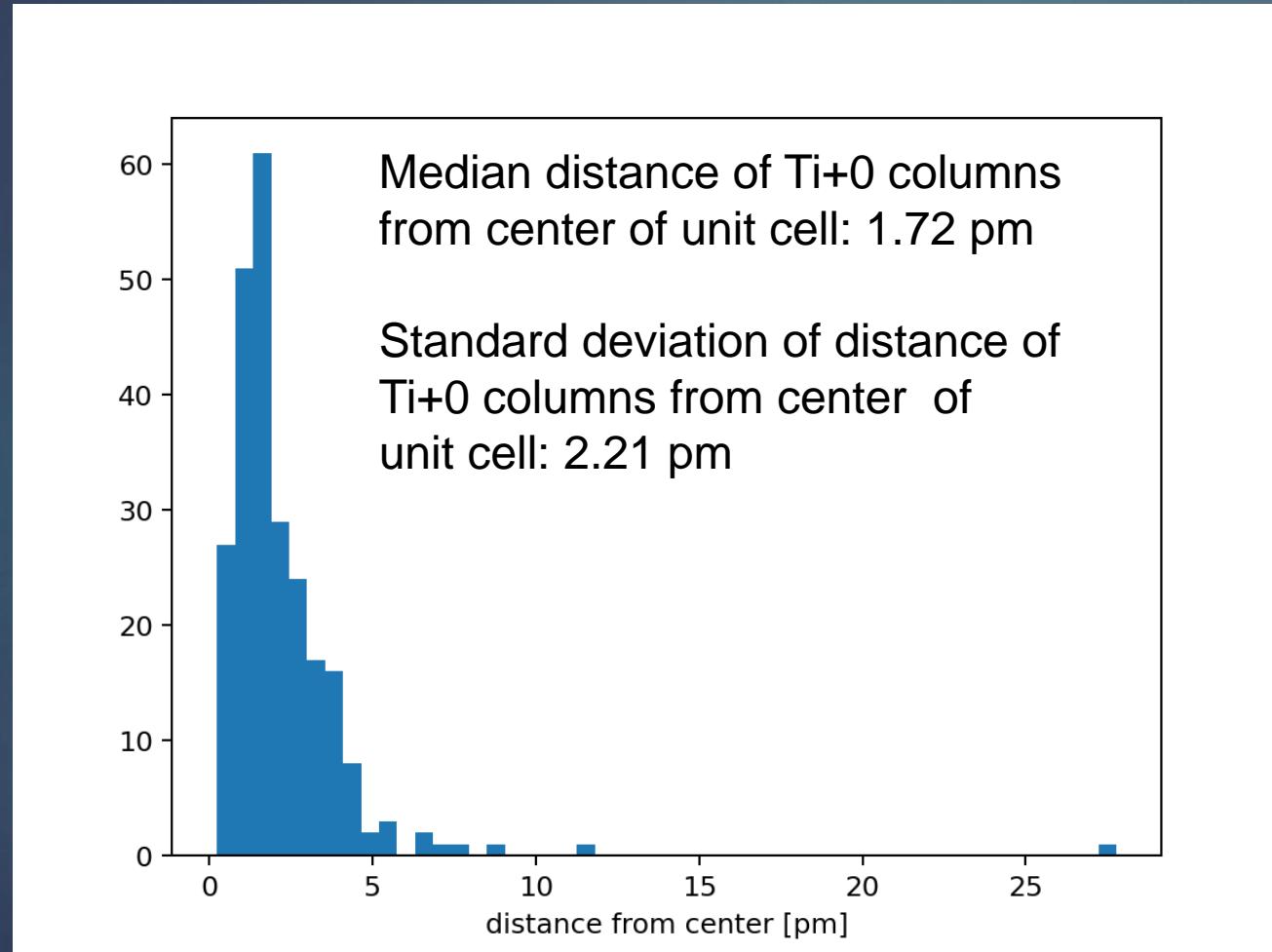


Evaluation of squares only  
Median angle deviation from square: 0.24 deg  
with standard deviation: 0.25 deg

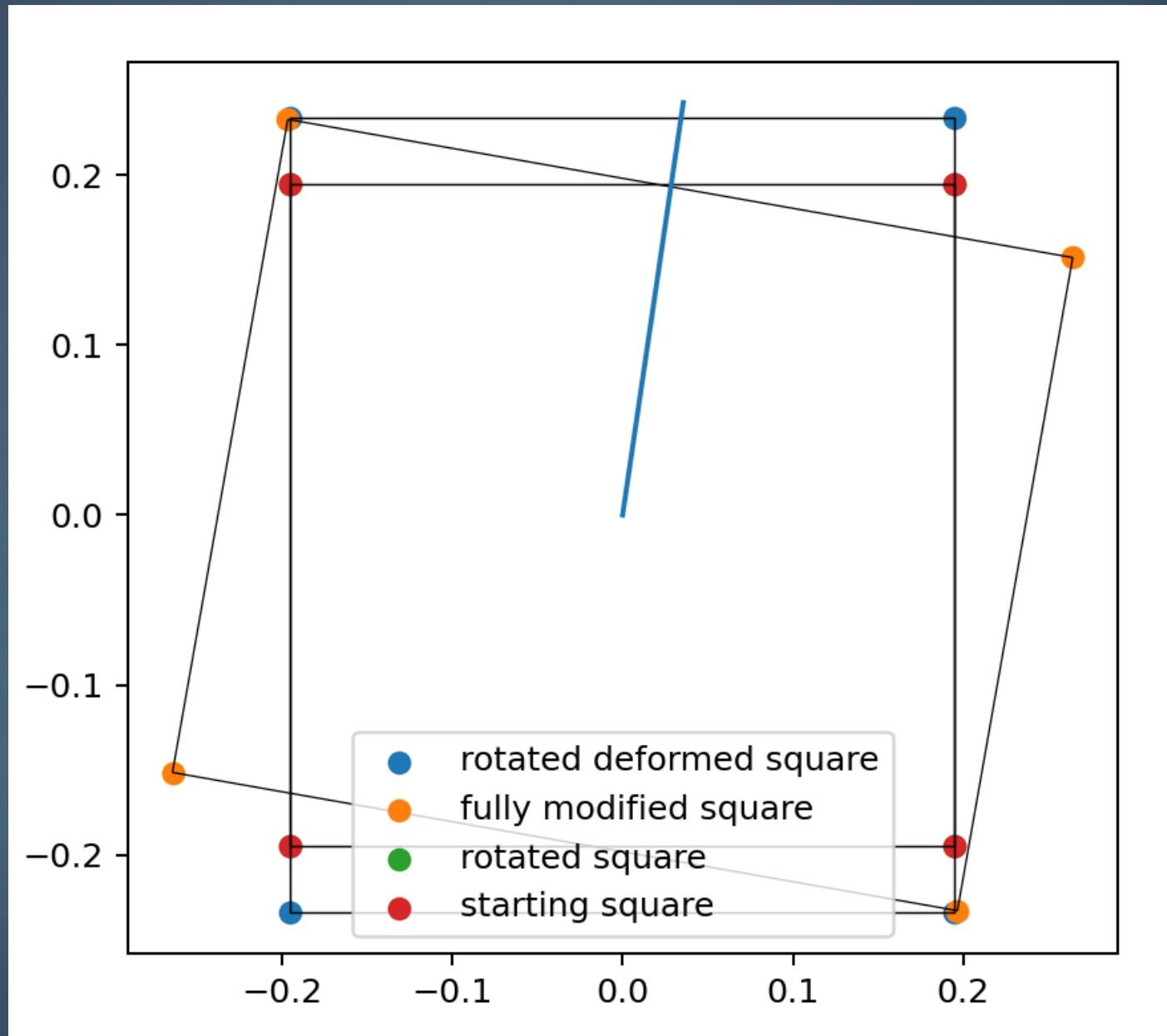


Median area:  $0.1525 \text{ nm}^2$   
which is  $0.3905 \text{ nm}$  squared  
with standard deviation:  $0.0009 \text{ nm}^2$   
which is  $1.0 \text{ pm}$  squared

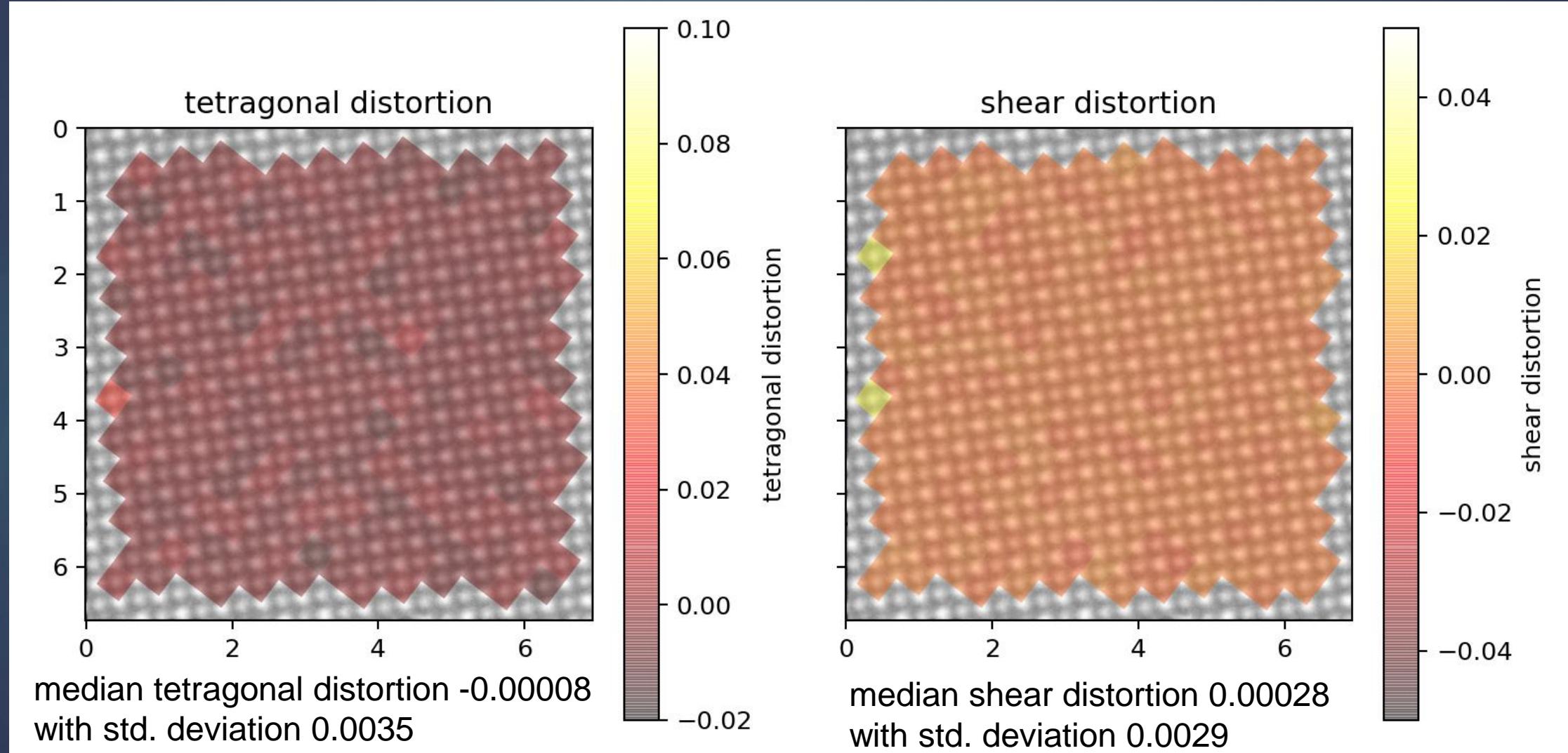
# Distance of Ti-O columns from center



# Strain



# Strain in Image



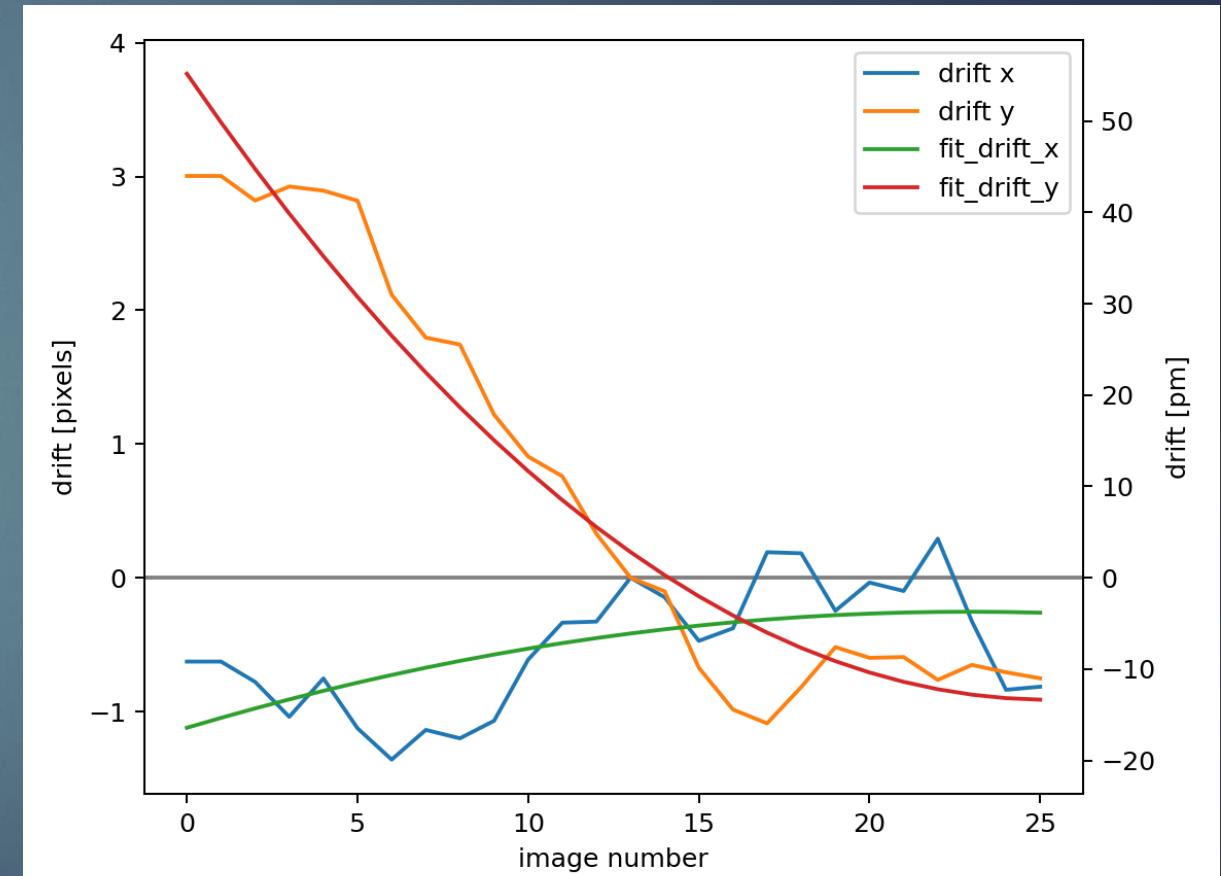
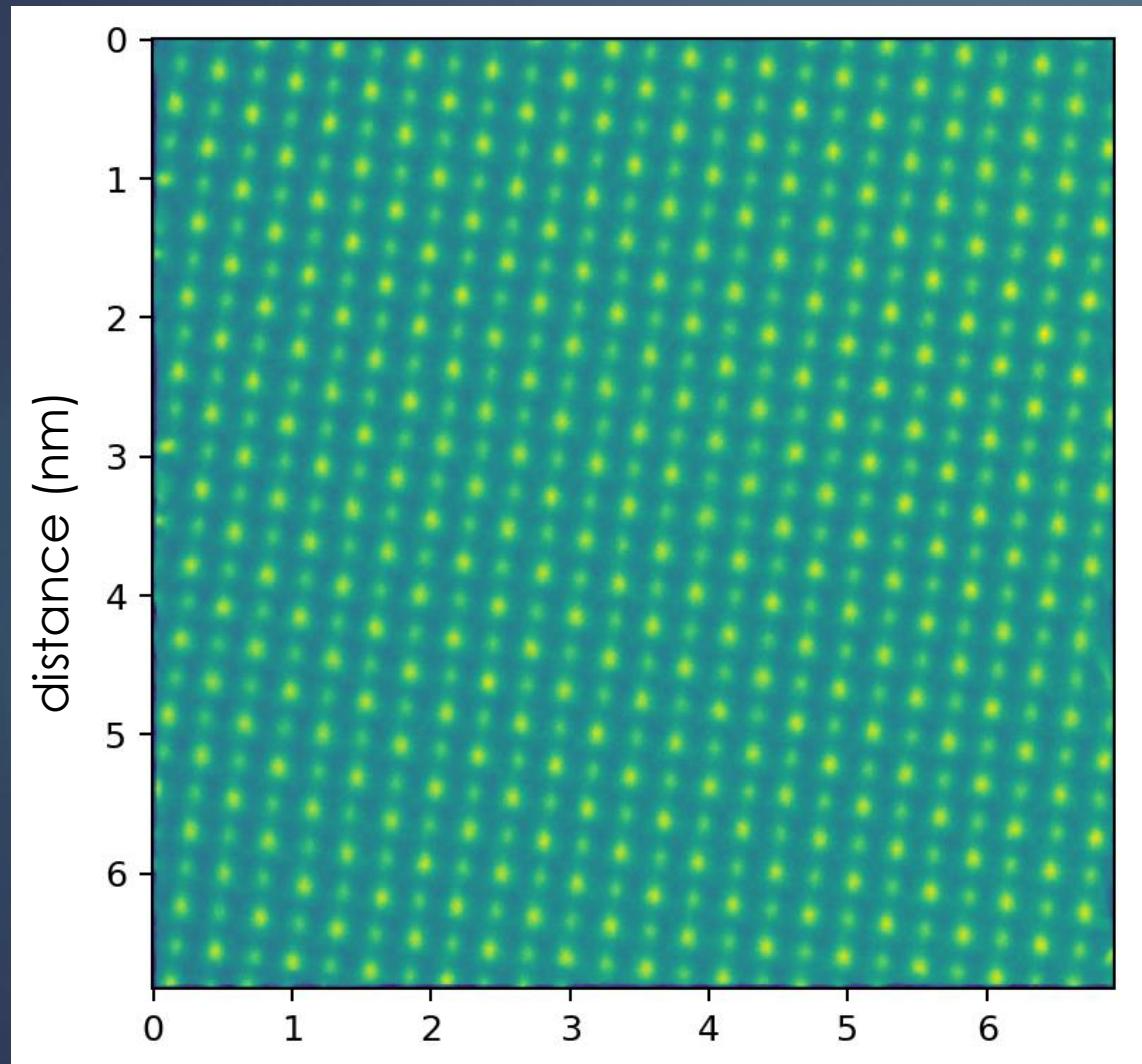
# Up to now

- ▶ Determination of minimal error
- ▶ Reached precision of relative positions almost to the level of Voyles group with similar method.

# Next

- ▶ Determine distortion matrix from reference dataset to correct another dataset.
  - ▶ Ideally, same sample
  - ▶ same rotation
  - ▶ same magnification
  - ▶ collection of both datasets within a short time frame

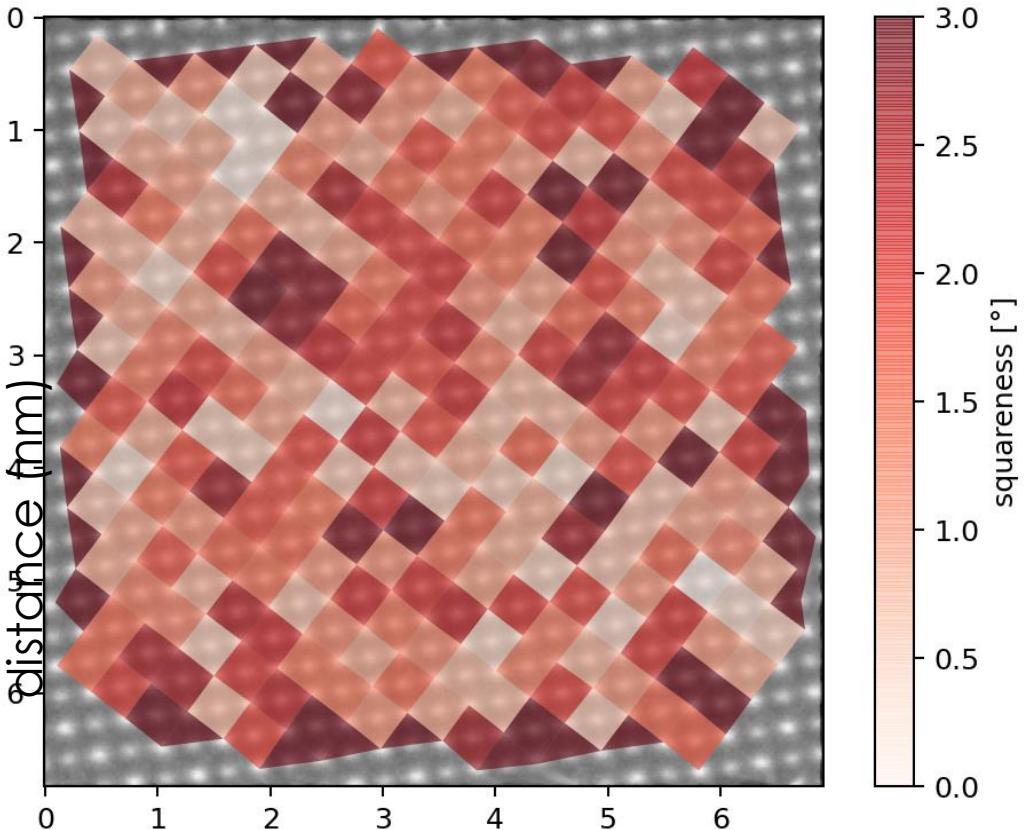
# Another Dataset



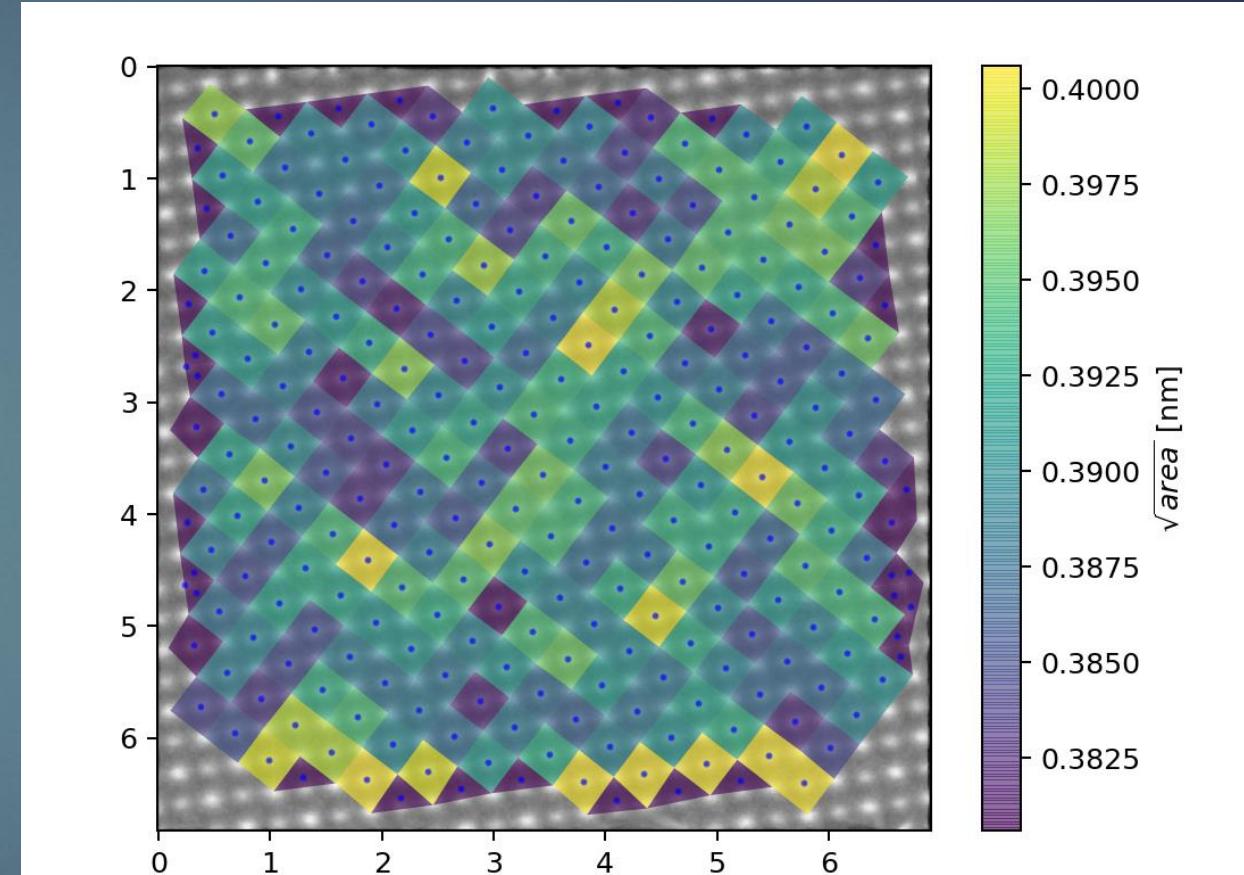
standard deviation of jitter in x direction: 5.45 pm  
standard deviation of jitter in y direction: 5.46 pm

# Unit Cell

pixel size is 14.6 pm



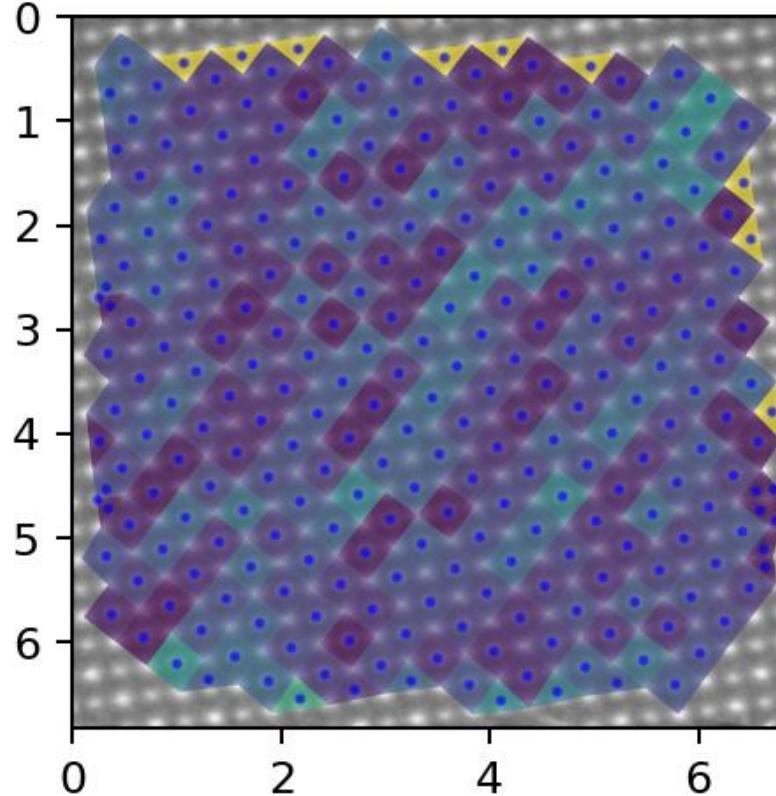
median angle deviation from square: 1.45 deg  
with standard deviation: 4.09 deg



median area: 0.1523 nm<sup>2</sup>  
which is 0.3903 nm squared  
with standard deviation: 0.0076 nm<sup>2</sup>  
which is 2.8 pm squared

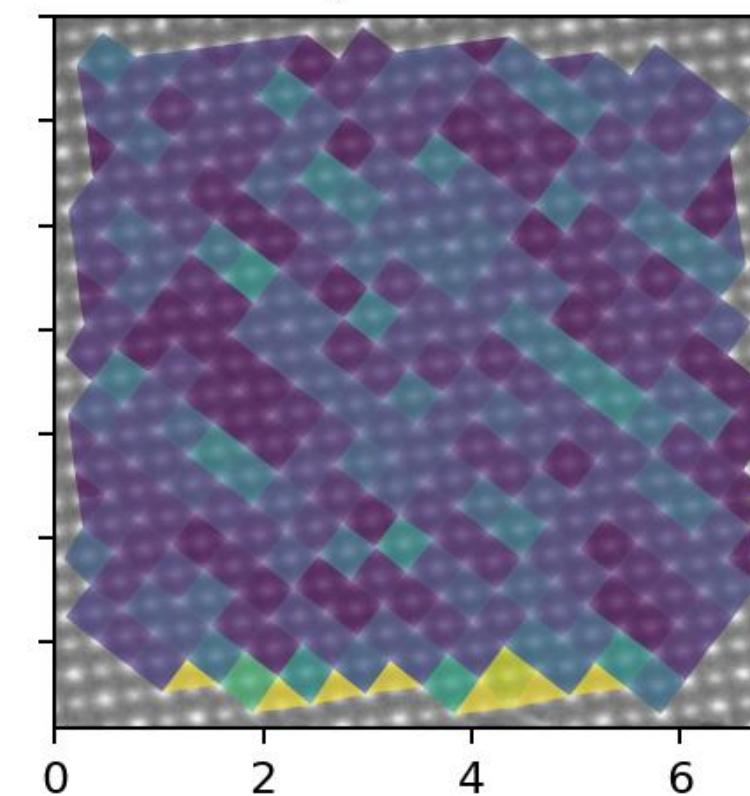
# Sides

smallest sides



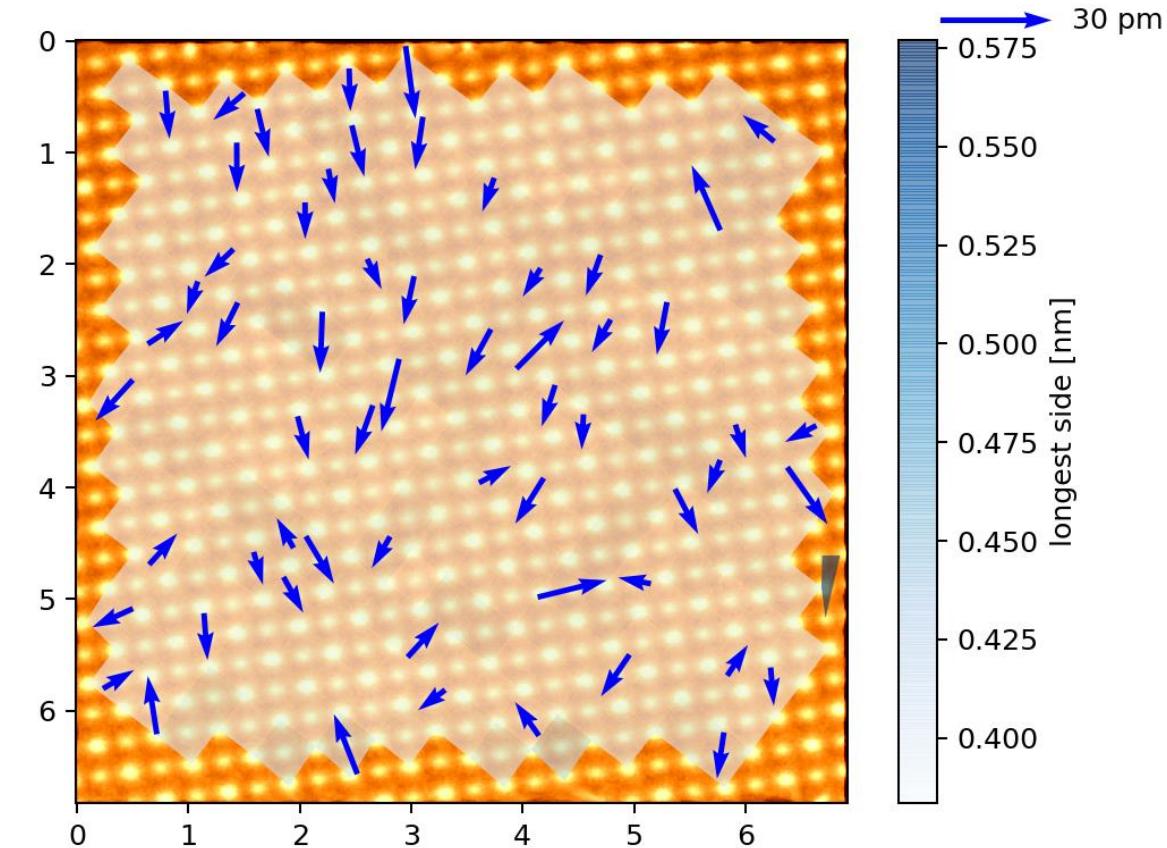
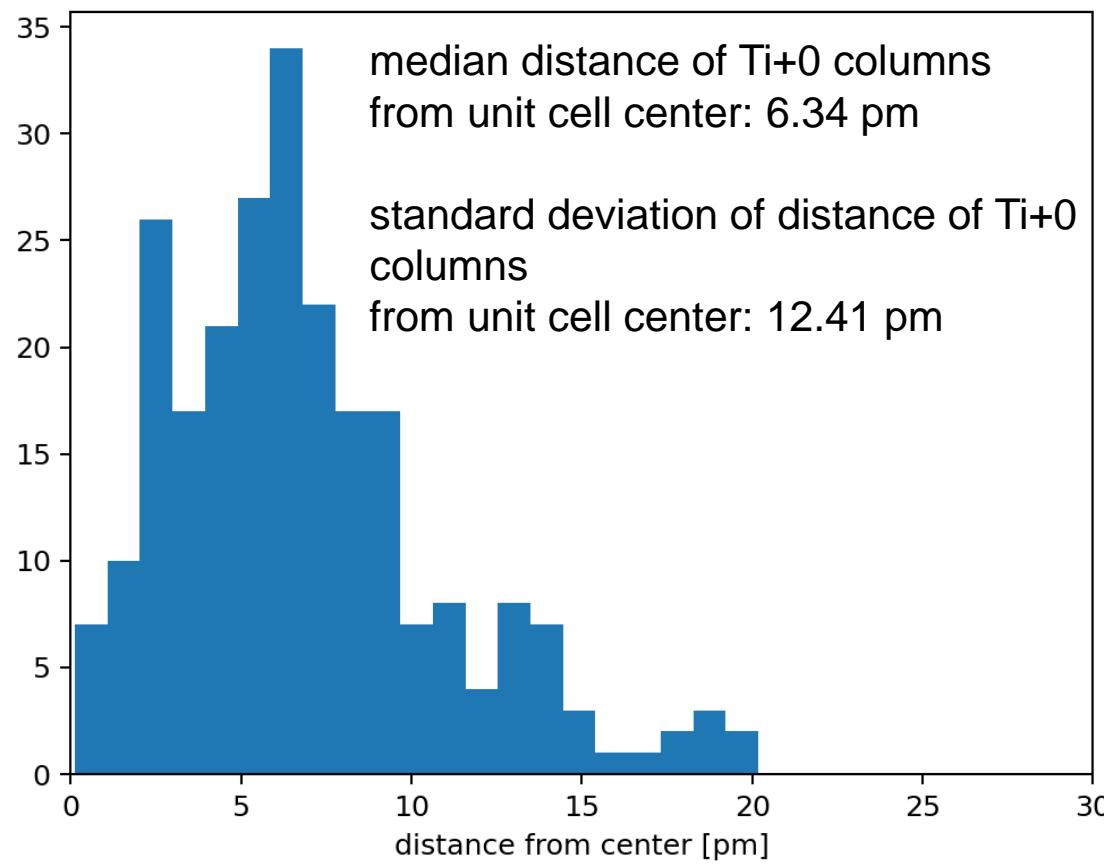
Median of smalles side: 0.3843 nm  
with standard deviation: 15.7 pm

longest sides

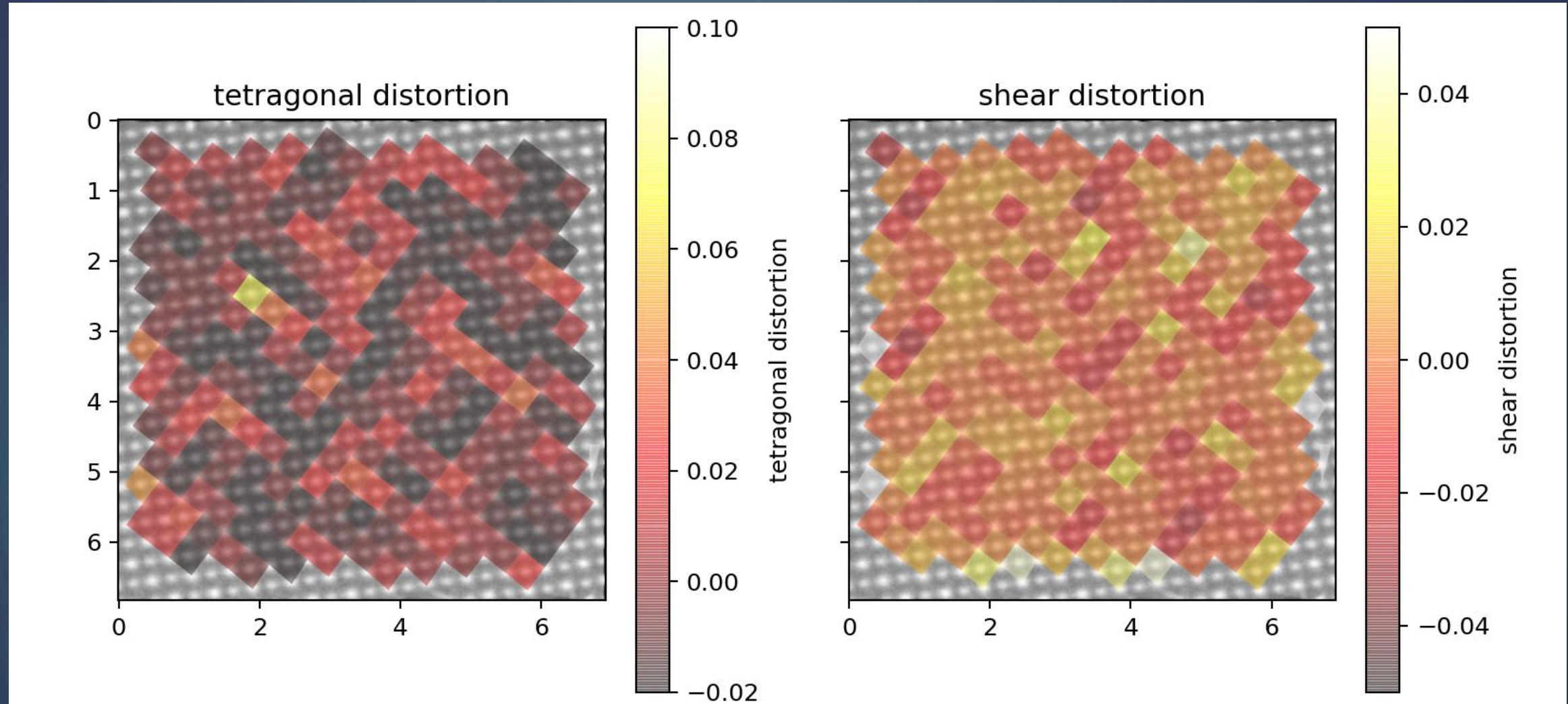


Median of longest side: 0.3967 nm  
with standard deviation: 13.4 pm

# Distance of Ti-O columns from center

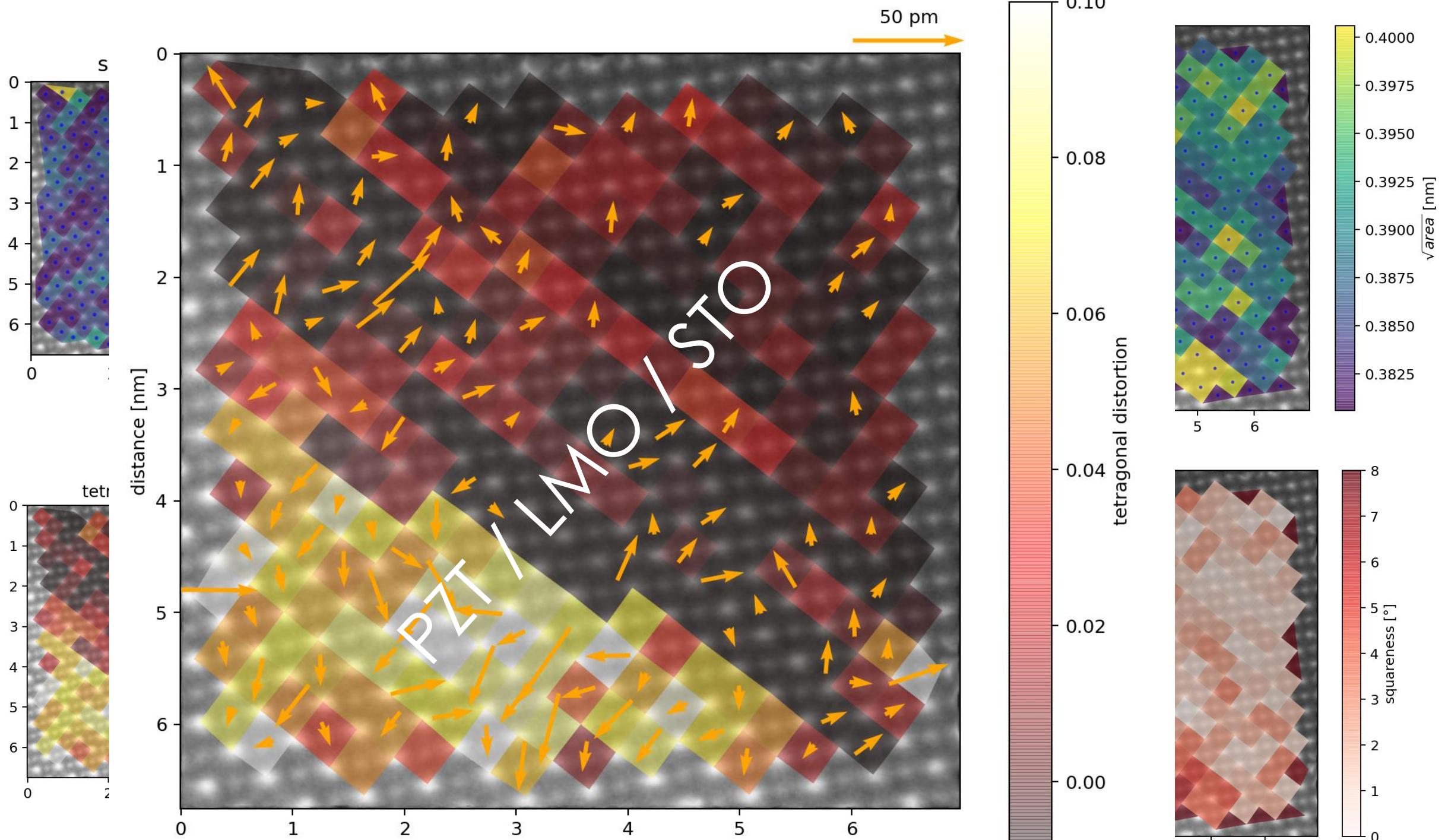


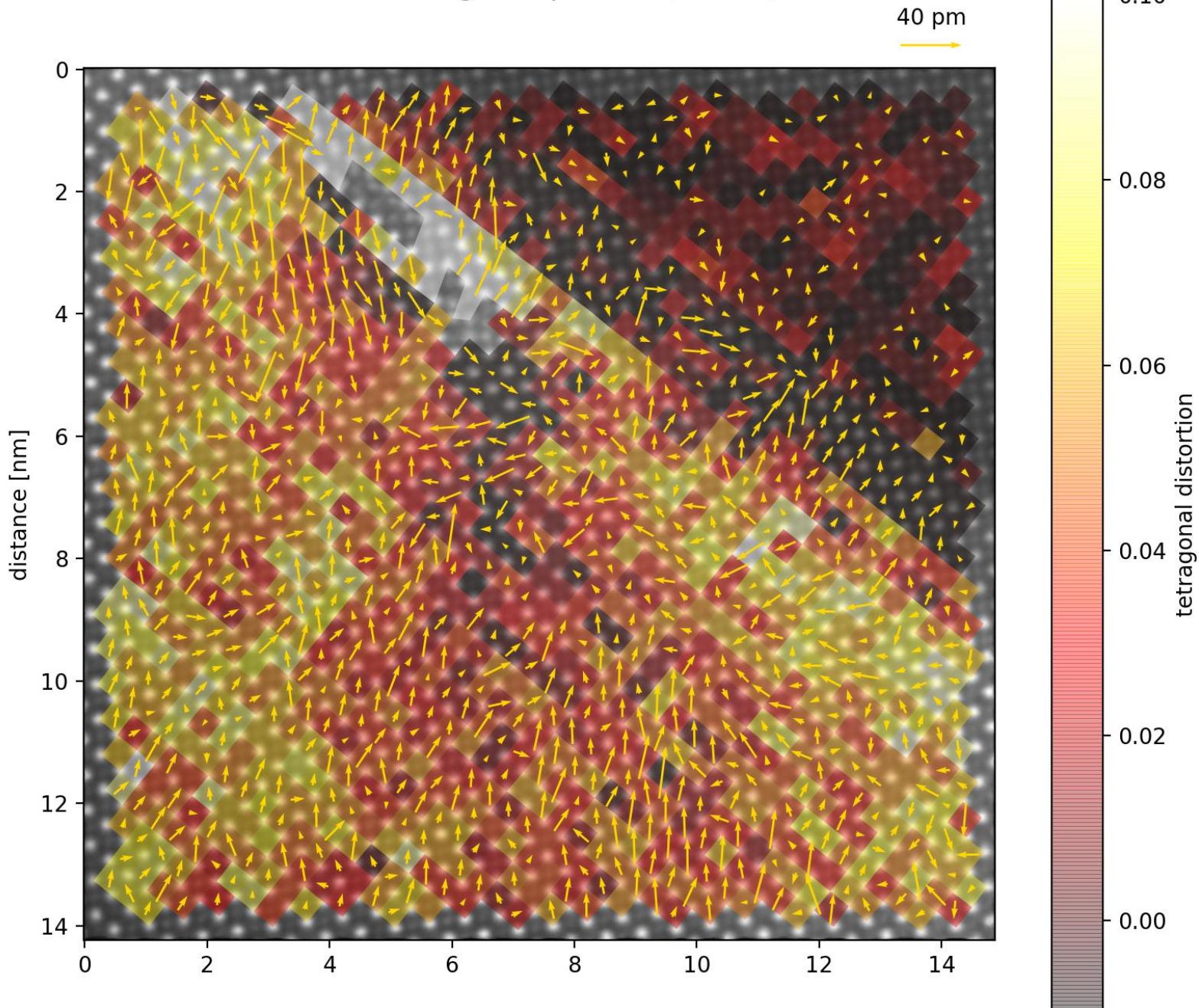
# Strain



median tetragonal distortion: -0.00300  
with std. deviation: 0.0502

median shear distortion: -0.00025  
with std. deviation: 0.0208





# STO/LMO/PZT

- ▶ Tetragonal distortion in PZT
- ▶ Compression in LMO
- ▶ Complicated polarization induced by interfacial dislocation

We see, that we need a larger view.

# Summary

- ▶ We showed how error bars for quantification can be determined
- ▶ Variation in scan distortion from dataset to dataset are limiting strain determination to less than a pixel.
- ▶ Strain determination benefitted from high brightness of cold field emitter and super stable sample stage in Nion.

# Outlook

- ▶ Demand good datasets, that can be quantified.
- ▶ Include noise in analysis.
- ▶ Use artificial intelligence algorithms for quantitative analysis.
- ▶ Good datasets for machine learning that are universally usable.
- ▶ Use machine learning on datasets from different sources.